

Notice of References Cited	Application/Control No. 10/805,702	Applicant(s)/Patent Under Reexamination WINICK, STEVEN J.	
	Examiner Nicole M. Young	Art Unit 2139	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0013867	01-2002	Matsuki et al.	710/22
*	B	US-2003/0041238	02-2003	French et al.	713/153
*	C	US-2003/0108018	06-2003	Dujardin et al.	370/338
*	D	US-2003/0191935	10-2003	Ferguson, Derek M.	713/153
*	E	US-4,980,913	12-1990	Skret, Daniel L.	713/153
*	F	US-2004/0030778	02-2004	Kronenberg et al.	709/224
*	G	US-2004/0212493	10-2004	Stilp, Louis A.	340/531
*	H	US-7,181,017	02-2007	Nagel et al.	380/282
*	I	US-6,279,113	08-2001	Vaidya, Vimal	726/23
*	J	US-6,079,033	06-2000	Jacobson et al.	714/47
*	K	US-2002/0091824	07-2002	Anderson et al.	709/225
*	L	US-2004/0024869	02-2004	Davies, Stephen W.	709/224
*	M	US-6,038,322	03-2000	Harkins, Dan	380/279

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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